

**Notice of References Cited**

 Application/Control No.  
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 Applicant(s)/Patent Under  
 Reexamination  
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,287,789	02-1994	Zimmerman, Thomas G.	84/454
	B	US-5,981,860 A	11-1999	Isozaki et al.	84/603
	C	US-5,524,060 A	06-1996	Silfvast et al.	381/104
	D	US-5,228,098 A	07-1993	Crinon et al.	382/240
	E	US-5,936,180 A	08-1999	Ando, Tokiharu	84/604
	F	US-4,957,552	09-1990	Iwase, Hiroyuki	84/622
	G	US-5,721,390 A	02-1998	Adachi et al.	84/602
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Iba et al (DERWENT 1991-206971 & 1992-225629) U.S. Patent 5,025,703 & (U.S. Patent 5,121,669 - June 1991 & 1992, resp
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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